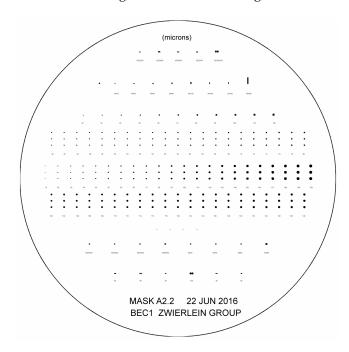
Name: **Huan Q. Bui** November 3, 2022

BEC1 mask fabrication proposal PI: Prof. Martin Zwierlein

Version: 2

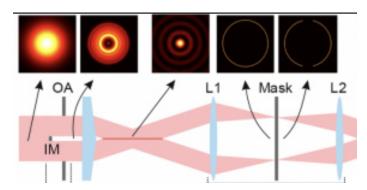
1. OBJECTIVE

The goal of this fabrication is to make an array of beam blockers for CW-laser application. The beam blockers are silver (Ag) circular masks of radii $\sim 100~\mu m$ that are deposited on a Thorlabs AR-coated glass window (N-BK7). The masks are distributed on the glass window according to the following pattern:



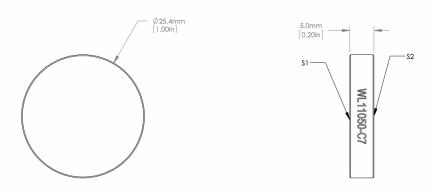
Note: the pattern sent to the MLA machine will be inverted due to the use of negative photoresist.

The BEC1 experiment creates an optical trap for ultracold atoms using 532 nm light in the form of a "coke can." The trap consists of one hollow beam and two end cap beams. The hollow beam is generated by using one of the masks in the pattern to block the central region of a Bessel beam. The diameter of the coke can can be controlled by selecting a circular mask of a particular size from the pattern. The setup in BEC1 is similar, but not identical, to the following schematic:



2. TENTATIVE PROCEDURE

(a) Acquire Thorlabs' WL11050-C7 glass window. Material N-BK7. Diameter: 1 inch. The glass window is AR-coated, suitable for 400-700 nm. The mask will be created on this glass window blank.



Other specifications:

Surface flatness: ≤ λ/10 at 633 nm
Surface quality: 10-5 scratch-dig
Thickness tolerance: ±0.3 mm

• Parallelism: ≤ 5 arcsec

- (b) Clean the N-BK7 window with acetone, followed by methanol, followed by IPA. Blow dry with N₂.
- (c) Spin AZ nLOF 2020 (negative) photoresist at approximately 3000 rpm for 30-60 seconds to approximately 2 μ m thickness. The optimal spin parameters will be determined during machine training/once the procedure starts.
- (d) Bake for 110°C for 90 seconds. Exact temperature and time to be determined.
- (e) Expose pattern with the MLA150 machine. Dosage: approximately 200 mJ/cm². The optimal dosage is determined by the age of the nLOF photoresist and is calibrated by MIT.nano's Dr. Hanqing Li.
- (f) Post-exposure baking (PEB). This step is required due to the use of negative photoresist. Bake at 110°C for 90 seconds.
- (g) Develop substrate. Time and temperature: to be determined.
- (h) Deposit a layer of silver (Ag) with thickness of 150 nm by electron-beam evaporation using the E-beam-Aja machine.
- (i) Silver liftoff: remove the photoresist and the silver that was deposited on the resist in the Microposit Remover 1165 overnight.
- (j) Solvent clean using acetone, followed by methanol, followed by IPA. Blow dry with N2.
- (k) Deposit a 20 nm-thick layer of SiO₂ on the entire substrate using CVD.